

SUPPORTING INFORMATION

for

**Reversal of methanation-oriented to RWGS-oriented Ni/SiO₂ catalyst
by the exsolution of Ni²⁺ confined in silicalite-1**

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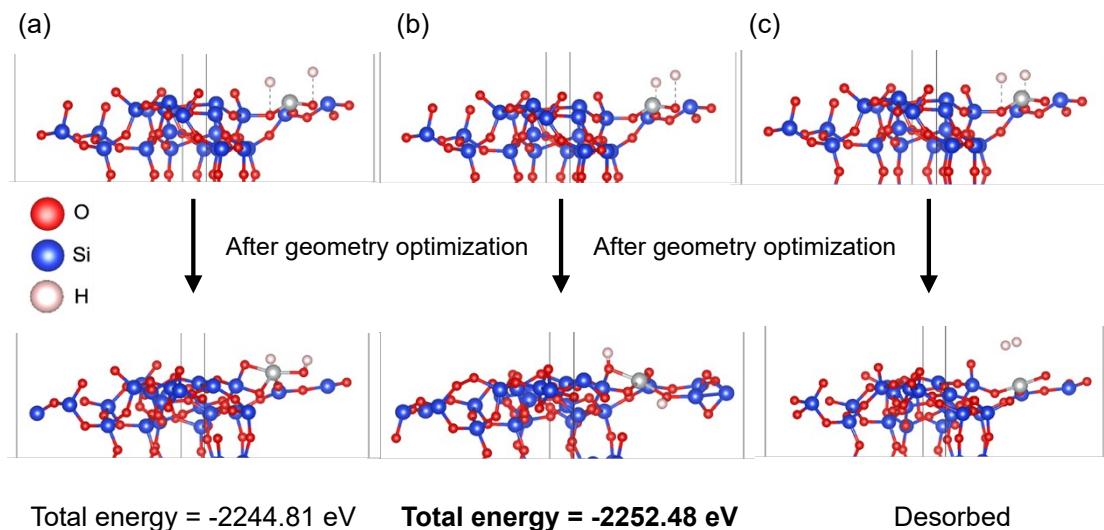


Figure S1. Three different configurations of the two H atoms on the surface of Ni@S-1, (a), (b), and (c). These configurations arise from the presence of three O atoms surrounding the Ni atom, resulting in three possible combinations. The (c) configuration did not yield a stable absorbed structure. On the other hand, the (b) configuration exhibited a relatively lower energy, making it the selected configuration for further analysis.

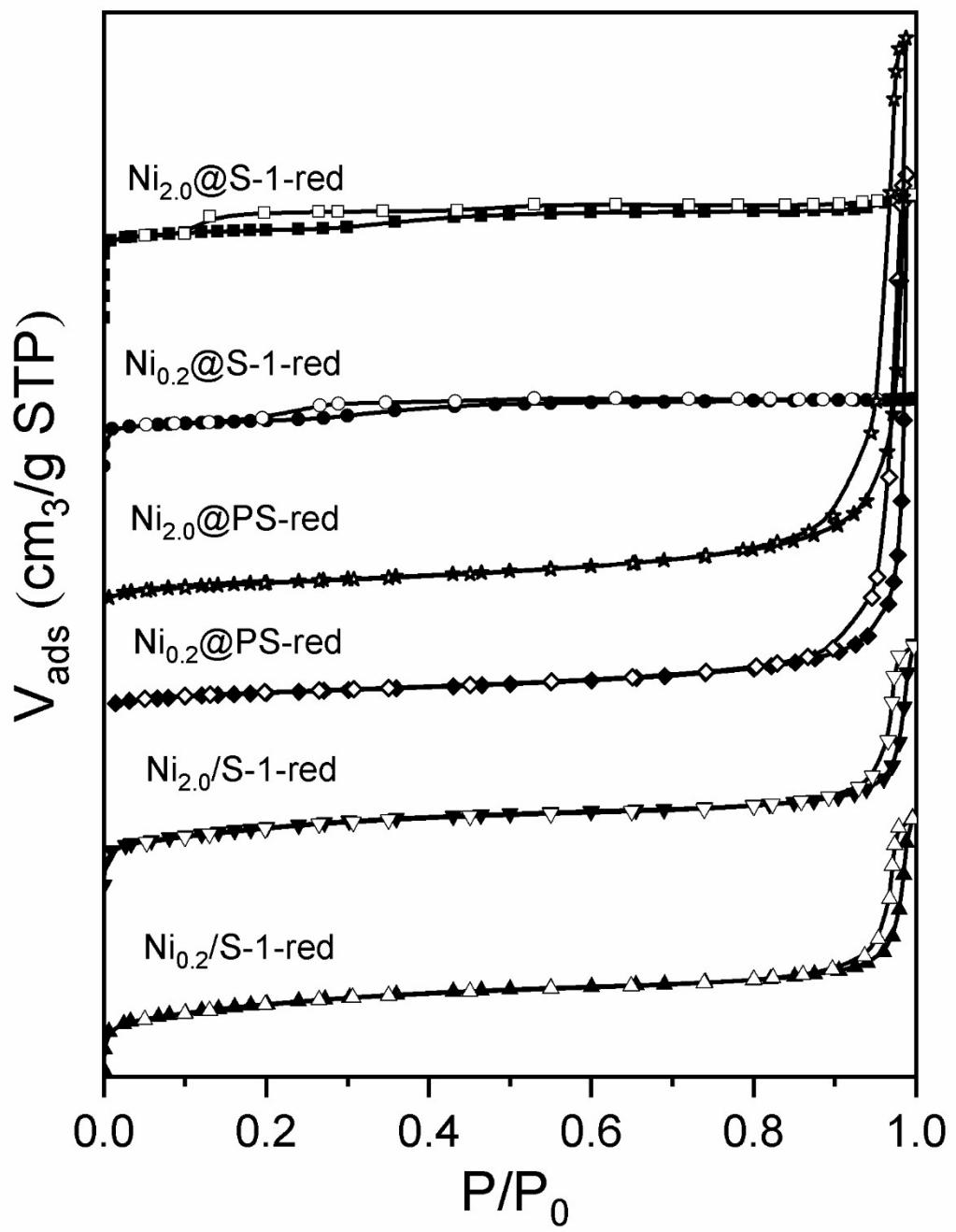


Figure S2. N₂ isotherms of tested catalysts.

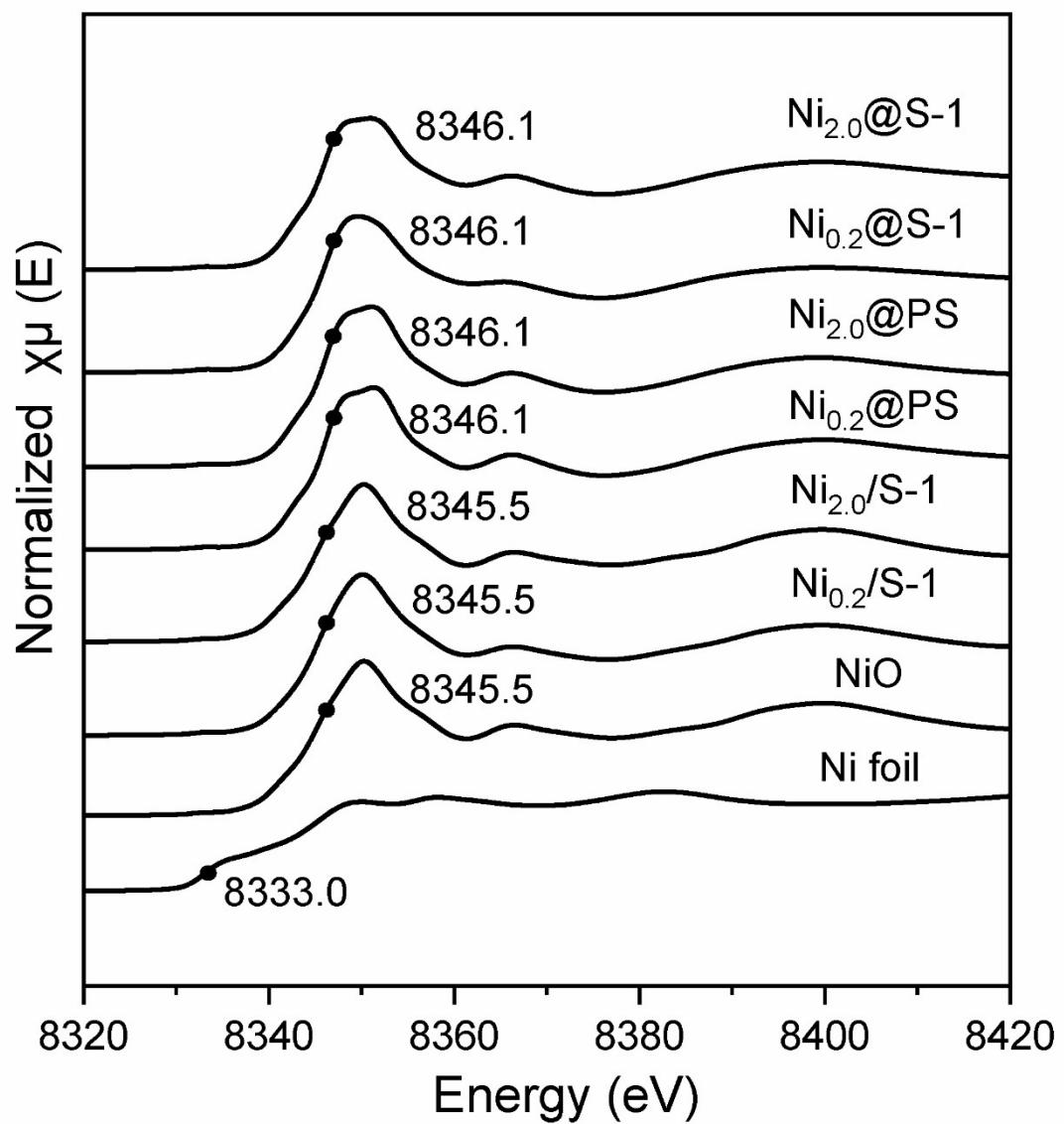


Figure S3. XANES spectra of the catalyst precursors at Ni *K*-edge.

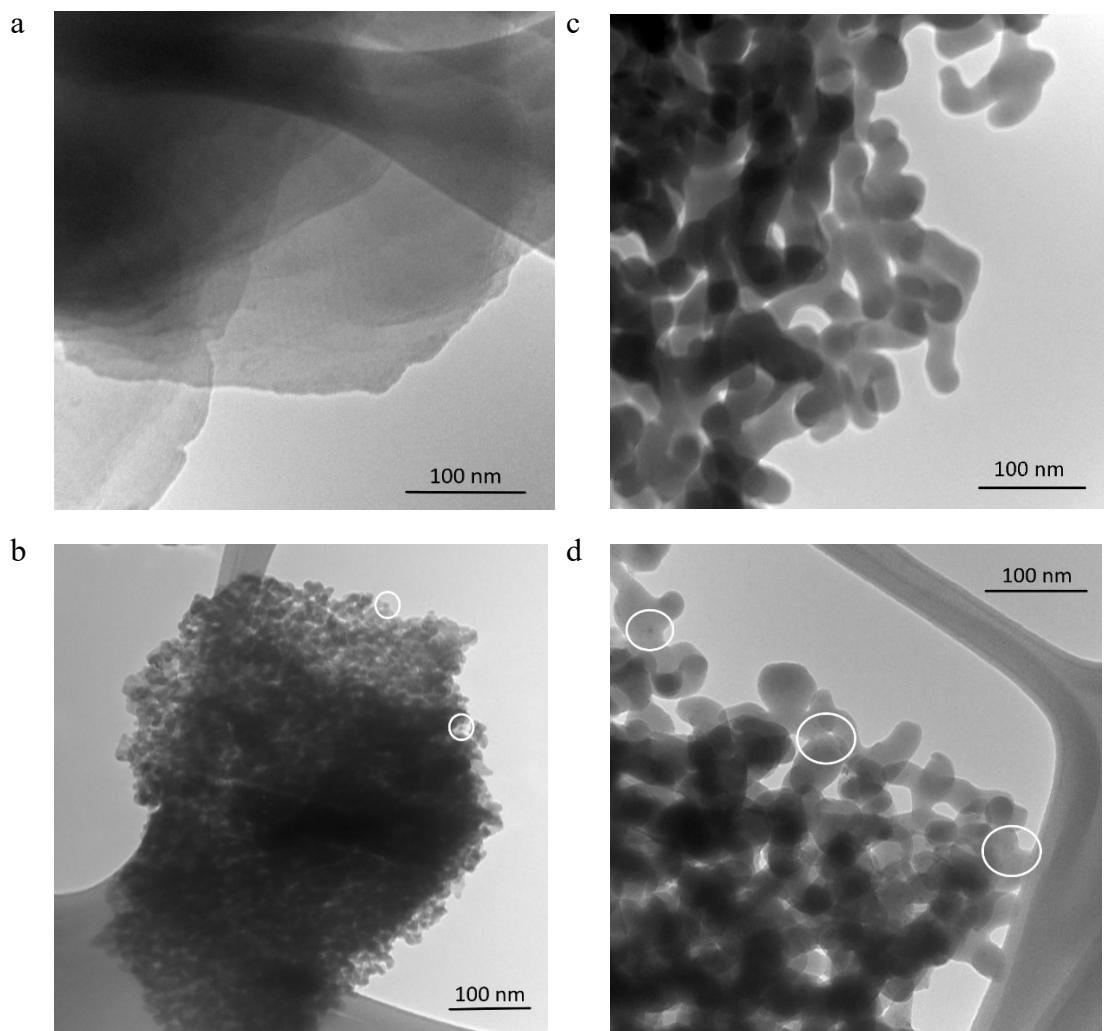
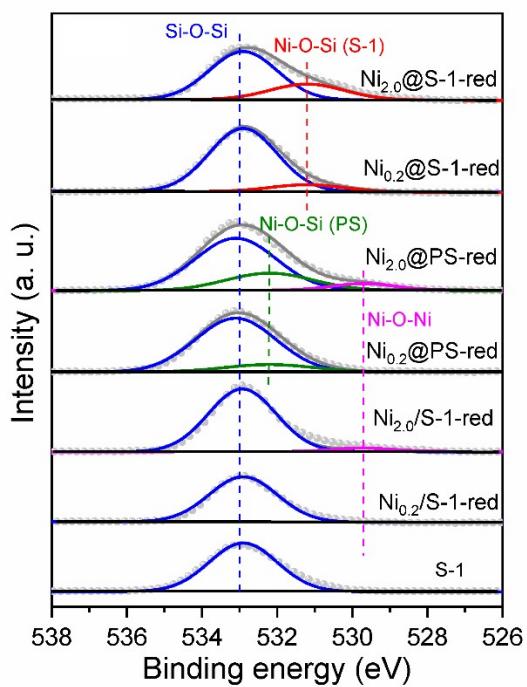


Figure S4. The TEM images of (a) $\text{Ni}_{0.2}/\text{S-1-red}$, (b) $\text{Ni}_{2.0}/\text{S-1-red}$, (c), $\text{Ni}_{0.2}@\text{PS-red}$, and (d) $\text{Ni}_{2.0}@\text{PS-red}$.

a



b

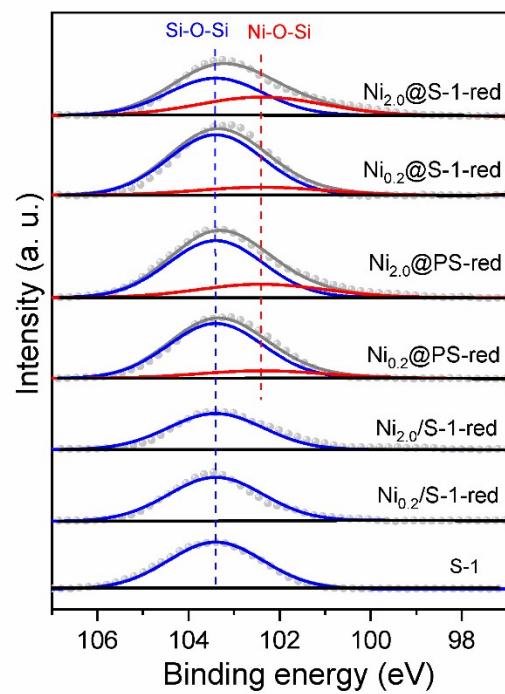


Figure S5. XPS spectra of (a) O 1s and (b) Si 2p photolines of the tested catalysts.

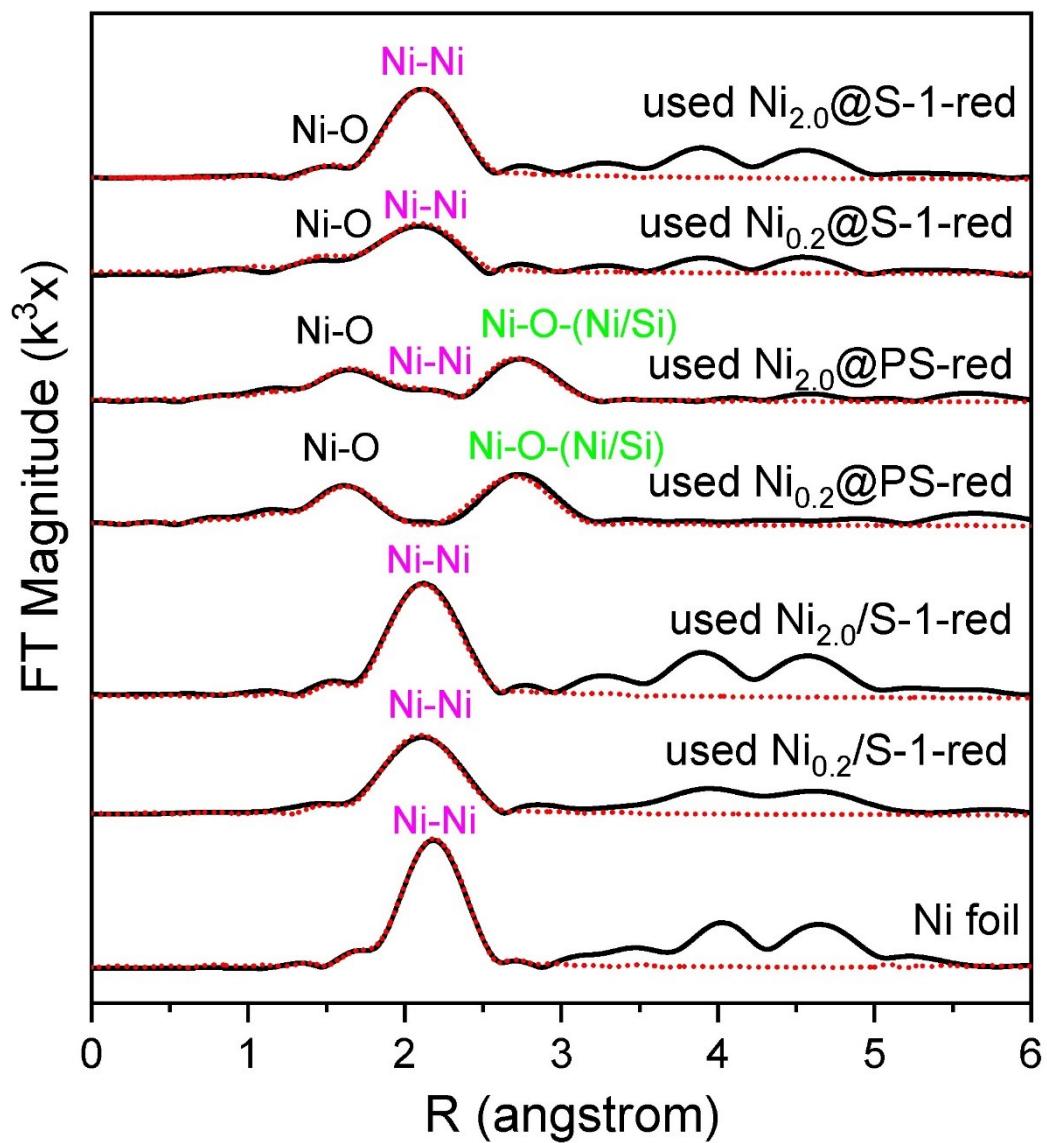


Figure S6. The RDF profiles of the used catalysts. The solid line represents the experimental data, and the dashed line represents the computer fit.

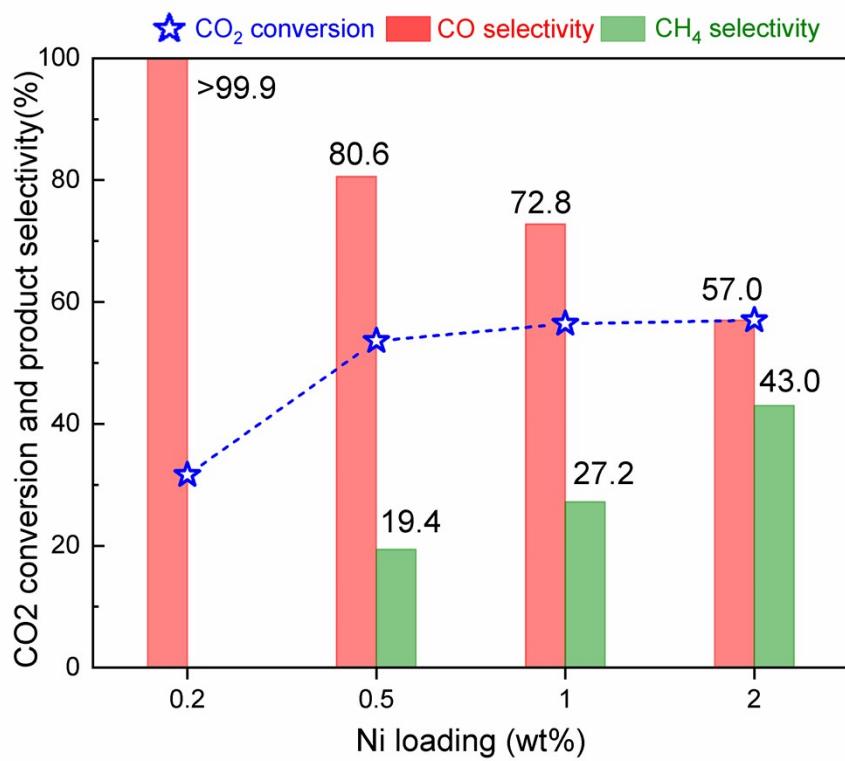
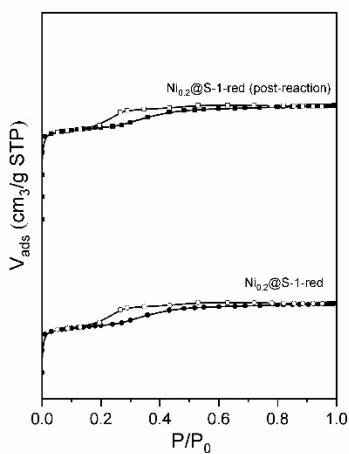
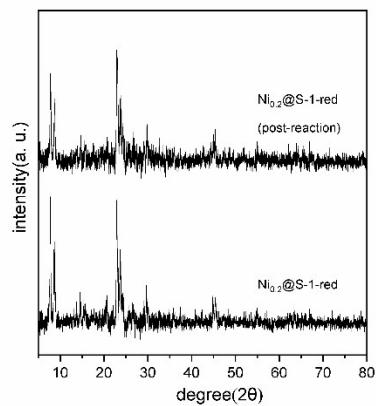


Figure S7. The activity tests of the $\text{Ni}_x@\text{S-1-red}$ catalysts ($x = 0.2, 0.5, 1.0$, and 2.0). Reaction conditions: $T = 450\text{ }^\circ\text{C}$, $P = 0.1\text{ MPa}$, $\text{H}_2/\text{CO}_2 = 3$, $\text{GHSV} = 12000\text{ mL/g}_{\text{Cat}}/\text{h}$.

a



b



c

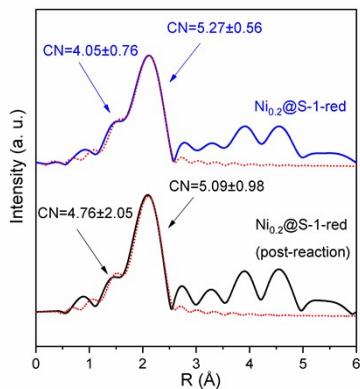


Figure S8. (a) N_2 isotherms, (b) XRD patterns, and (c) RDF profiles of the EXAFS spectra of the fresh and the after 100 h on-stream tested $\text{Ni}_{0.2}\text{@S-1-red}$ catalysts.

Table S1. Parameters obtained from the fitting results of the EXAFS data at Ni *K*-edge of the catalyst precursors.

Sample	Scattering path	CN ^a	R (Å) ^b	σ2 (Å ²) ^c	R-factor
Ni _{2.0} @S-1	1st (Ni-O)	5.58 ± 0.66	2.06 ± 0.01	0.004	0.011
	2nd (Ni-O-(Ni/Si))	7.12 ± 1.43	3.06 ± 0.01	0.008	
Ni _{0.2} @S-1	1st (Ni-O)	5.75 ± 0.62	2.04 ± 0.01	0.006	0.007
	2nd (Ni-O-Si)	3.12 ± 1.06	3.03 ± 0.01	0.008	
Ni _{2.0} @PS	1st (Ni-O)	6.11 ± 0.66	2.07 ± 0.01	0.005	0.009
	2nd (Ni-O-(Ni/Si))	8.07 ± 1.33	3.06 ± 0.01	0.008	
Ni _{0.2} @PS	1st (Ni-O)	6.16 ± 0.69	2.07 ± 0.01	0.004	0.009
	2nd (Ni-O-(Ni/Si))	8.69 ± 1.40	3.05 ± 0.01	0.008	
Ni _{2.0} /S-1	1st (Ni-O)	6.48 ± 1.02	2.06 ± 0.01	0.005	0.008
	2nd (Ni-O-Ni)	11.79 ± 1.37	2.95 ± 0.01	0.006	
Ni _{0.2} /S-1	1st (Ni-O)	6.41 ± 0.73	2.06 ± 0.01	0.006	0.005
	2nd (Ni-O-Ni)	10.41 ± 1.22	2.96 ± 0.01	0.008	
NiO	1st (Ni-O)	6	2.07 ± 0.01	0.006	0.003
	2nd (Ni-O-Ni)	12	2.95 ± 0.01	0.006	

a: coordination number; b: interatomic distance; c: Debye-Waller factor

Table S2. Parameters obtained from the fitting results of the EXAFS data at Ni *K*-edge of the fresh catalysts.

Sample	Scattering path	CN ^a	R (Å) ^b	σ2 (Å ²) ^c	R-factor
Ni _{2.0} @S-1-red	1st (Ni-O)	1.61 ± 1.05	2.03 ± 0.03	0.011	0.001
	2nd (Ni-Ni)	8.42 ± 0.59	2.48 ± 0.01	0.006	
Ni _{0.2} @S-1-red	1st (Ni-O)	4.05 ± 0.76	2.02 ± 0.01	0.009	0.003
	2nd (Ni-Ni)	5.27 ± 0.56	2.48 ± 0.01	0.006	
Ni _{2.0} @PS-red	1st (Ni-O)	5.23 ± 0.88	2.07 ± 0.02	0.004	
	2nd (Ni-Ni)	1.39 ± 2.69	2.48 ± 0.03	0.006	0.007
	3rd (Ni-O-(Ni/Si))	6.39 ± 2.47	3.06 ± 0.02	0.007	
Ni _{0.2} @PS-red	1st (Ni-O)	5.87 ± 0.70	2.06 ± 0.01	0.004	0.009
	2nd (Ni-O-(Ni/Si))	8.50 ± 1.70	3.05 ± 0.01	0.009	
Ni _{2.0} /S-1-red	1st (Ni-Ni)	10.39 ± 0.54	2.48 ± 0.01	0.005	0.002
Ni _{0.2} /S-1-red	1st (Ni-Ni)	10.03 ± 1.39	2.48 ± 0.01	0.007	0.013
Ni foil	1st (Ni-Ni)	12	2.48 ± 0.01	0.005	0.001

a: coordination number; b: interatomic distance; c: Debye-Waller factor

Table S3. Parameters obtained from the fitting results of the EXAFS data at Ni *K*-edge of the used catalysts.

Sample	Scattering path	CN ^a	R (Å) ^b	σ2 (Å ²) ^c	R-factor
Ni _{2.0} @S-1-spent	1st (Ni-O)	1.60 ± 1.09	2.03 ± 0.03	0.011	0.001
	2nd (Ni-Ni)	8.26 ± 0.55	2.48 ± 0.01	0.005	
Ni _{0.2} @S-1-spent	1st (Ni-O)	4.76 ± 2.05	2.02 ± 0.02	0.012	0.011
	2nd (Ni-Ni)	5.09 ± 0.98	2.47 ± 0.01	0.006	
Ni _{2.0} @PS-spent	1st (Ni-O)	5.27 ± 0.76	2.07 ± 0.02	0.004	
	2nd (Ni-Ni)	1.47 ± 2.43	2.48 ± 0.03	0.007	0.008
	3rd (Ni-O-(Ni/Si))	6.28 ± 2.07	3.06 ± 0.02	0.007	
Ni _{0.2} @PS-spent	1st (Ni-O)	5.81 ± 0.68	2.06 ± 0.01	0.004	0.014
	2nd (Ni-O-(Ni/Si))	8.20 ± 1.61	3.06 ± 0.01	0.009	
Ni _{2.0} /S-1-spent	1st (Ni-Ni)	10.42 ± 0.68	2.48 ± 0.01	0.005	0.004
Ni _{0.2} /S-1-spent	1st (Ni-Ni)	10.12 ± 1.39	2.48 ± 0.01	0.007	0.014
Ni foil	1st (Ni-Ni)	12	2.48 ± 0.01	0.005	0.001

a: coordination number; b: interatomic distance; c: Debye-Waller factor